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And

radar In: All Fields

And

lfm In: All Fields

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Terms	Documents
L10 and chirp\$4	1

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side by side

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result set

*DB=TDBD; PLUR=YES; OP=OR*

<u>L13</u>	l10 and chirp\$4	1	<u>L13</u>
<u>L12</u>	l10 and l11	0	<u>L12</u>
<u>L11</u>	((linear adj frequency adj modulat\$3) or lfm)	2	<u>L11</u>
<u>L10</u>	tag\$1 or responder\$1 or transponder\$1	1065	<u>L10</u>

*DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI; PLUR=YES; OP=OR*

<u>L9</u>	l4 and chirp\$4.ti,ab.	23	<u>L9</u>
<u>L8</u>	l2 and chirp\$4.ti,ab.	1	<u>L8</u>
<u>L7</u>	l6 not l3	7	<u>L7</u>
<u>L6</u>	l4 and l5	9	<u>L6</u>
<u>L5</u>	((linear adj frequency adj modulat\$3) or lfm)	1271	<u>L5</u>
<u>L4</u>	(tag\$1 or responder\$1 or transponder\$1).ti,ab.	52952	<u>L4</u>
<u>L3</u>	((linear adj frequency adj modulat\$3) or lfm) and l2	2	<u>L3</u>
<u>L2</u>	(tag\$1 or responder\$1 or transponder\$1).ti,ab. and l1	713	<u>L2</u>
<u>L1</u>	radar\$1.ti,ab.	42996	<u>L1</u>

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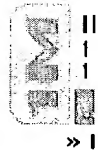
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And

frequency In: All Fields

And

modulation In: All Fields

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tag&lt;and&gt;frequency&lt;and&gt;modulation

Search

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## 1 An active tagging system using circular-polarization modulation

Kossel, M.A.; Kung, R.; Benedickter, H.; Biichtokd, W.;

Microwave Theory and Techniques, IEEE Transactions on , Volume: 47 , Issue 12 , Dec. 1999

Pages:2242 - 2248

[\[Abstract\]](#)[\[PDF Full-Text \(388 KB\)\]](#)

IEEE JNL

## 2 An overview of backscattered radio frequency identification system (RFID)

Rao, K.V.S.;

Microwave Conference, 1999 Asia Pacific , Volume: 3 , 30 Nov.-3 Dec. 1999

Pages:746 - 749 vol.3

[\[Abstract\]](#)[\[PDF Full-Text \(276 KB\)\]](#)

IEEE CNF

## 3 Optimal tag pattern validation using magnetic resonance imaging

Denney, T.S., Jr.; Prince, J.L.; Lopez, M.J.; McVeigh, E.R.;

Image Processing, 1994. Proceedings. ICIP-94., IEEE International Conference , Volume: 1 , 13-16 Nov. 1994

Pages:881 - 885 vol.1

[\[Abstract\]](#)[\[PDF Full-Text \(372 KB\)\]](#)

IEEE CNF

## 4 Microwave backscatter modulation systems

Kossel, M.; Benedickter, H.R.; Peter, R.; Bachtold, W.;

Microwave Symposium Digest., 2000 IEEE MTT-S International , Volume: 3 , June 2000

Pages:1427 - 1430 vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(292 KB\)\]](#) **IEEE CNF**

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**5 Optimization of inductive RFID technology**

*Chen, S.C.Q.; Thomas, V.;*

Electronics and the Environment, 2001. Proceedings of the 2001 IEEE International Symposium on , 7-9 May 2001

Pages:82 - 87

[\[Abstract\]](#) [\[PDF Full-Text \(416 KB\)\]](#) **IEEE CNF**

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**6 Passive 5.8-GHz radio-frequency identification tag for monitoring of pipe**

*Strassner, B.; Kai Chang;*

Microwave Theory and Techniques, IEEE Transactions on , Volume: 51 , Issue: 2 , Feb. 2003

Pages:356 - 363

[\[Abstract\]](#) [\[PDF Full-Text \(577 KB\)\]](#) **IEEE JNL**

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**7 Fully integrated passive UHF RFID transponder IC with 16.7-/spl mW minimum RF input power**

*Karthauss, U.; Fischer, M.;*

Solid-State Circuits, IEEE Journal of , Volume: 38 , Issue: 10 , Oct. 2003

Pages:1602 - 1608

[\[Abstract\]](#) [\[PDF Full-Text \(503 KB\)\]](#) **IEEE JNL**

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**8 A global SAW ID tag with large data capacity**

*Hartmann, C.S.;*

Ultrasonics Symposium, 2002. Proceedings. 2002 IEEE , Volume: 1 , 8-11 Oct 2002

Pages:65 - 69 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(395 KB\)\]](#) **IEEE CNF**

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**9 Short range UHF telemetry system using passive transponders for vehicle ID and status information**

*Koelle, A.R.;*

Automotive Applications of Electronics, 1988., IEEE Workshop on , 19 Oct. 1988

Pages:34 - 38

[\[Abstract\]](#) [\[PDF Full-Text \(440 KB\)\]](#) **IEEE CNF**

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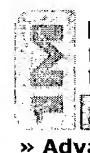


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Example: optical <and> (fiber <or> fibre) <in> ti
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